

香港中文大學

The Chinese University of Hong Kong

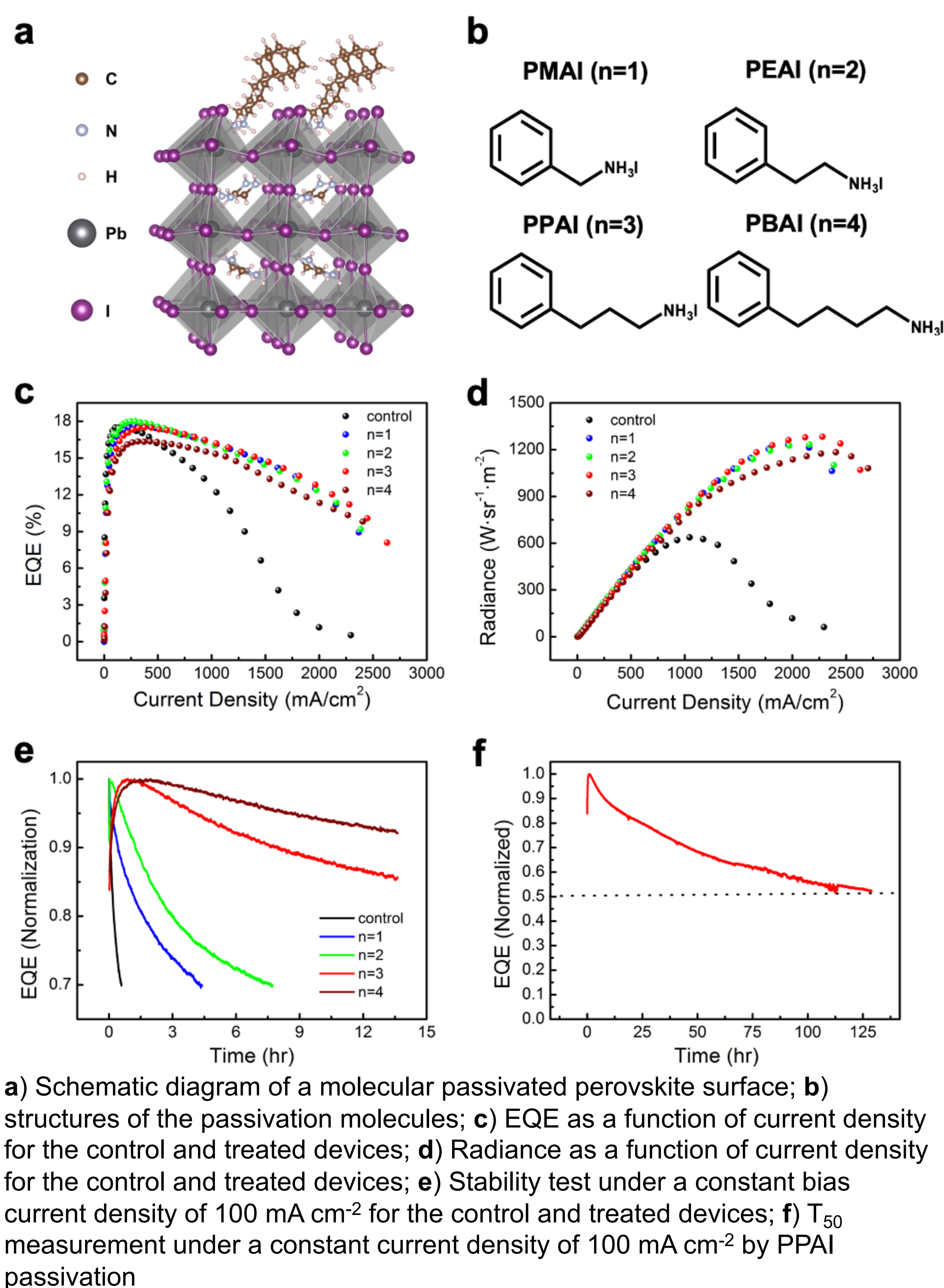
Perovskite Light Emitting Diodes with Record High-radiance Operational Lifetime by Phenylalkylammonium Passivation

Yuwei Guo¹, Sofia Apergi^{2,3}, Nan Li¹, Mengyu Chen^{1,4}, Chunyang Yin⁵, Zhongcheng Yuan⁵, Feng Gao⁵, Fangyan Xie⁶, Geert Brocks^{2,3,7}, Shuxia Tao^{2,3*}, Ni Zhao^{1*}

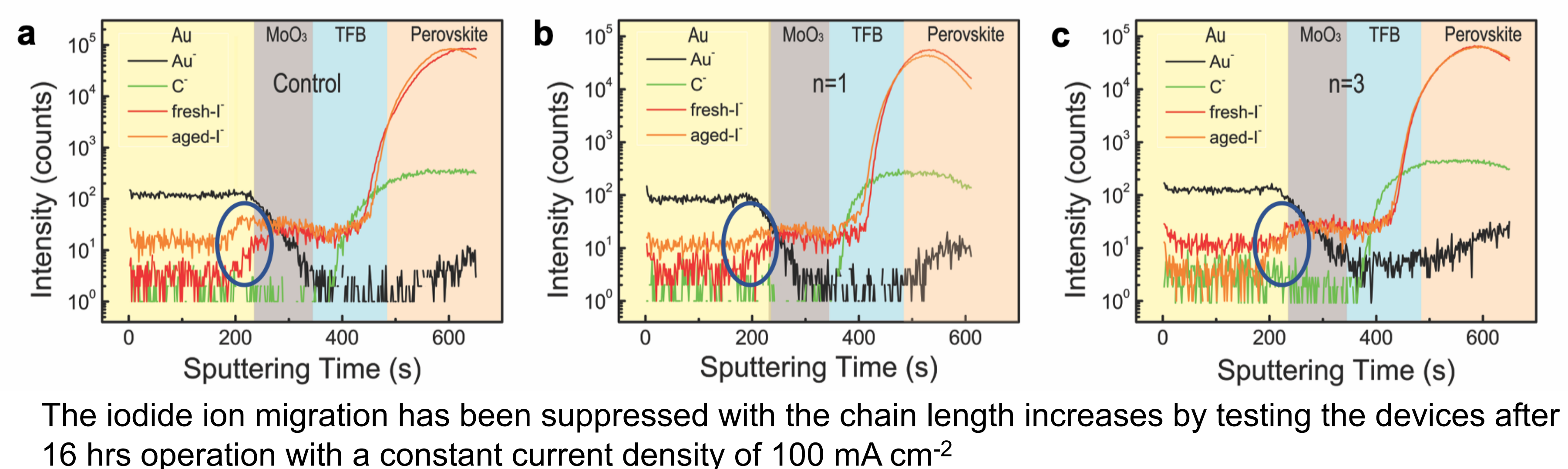
Introduction

Perovskite-based light emitting diodes (PeLEDs) display has a great potential in the display field. The past few years have seen a significant improvement in the efficiency of PeLEDs. However, the poor operation stability of the devices still hinders the commercialization of this technology in practical applications, exhibiting a rapid decay of external quantum efficiency (EQE) within minutes to hours during operation. To address this issue, we explore surface treatment of perovskite films with phenylalkylammonium iodide molecules of varying alkyl chain lengths.

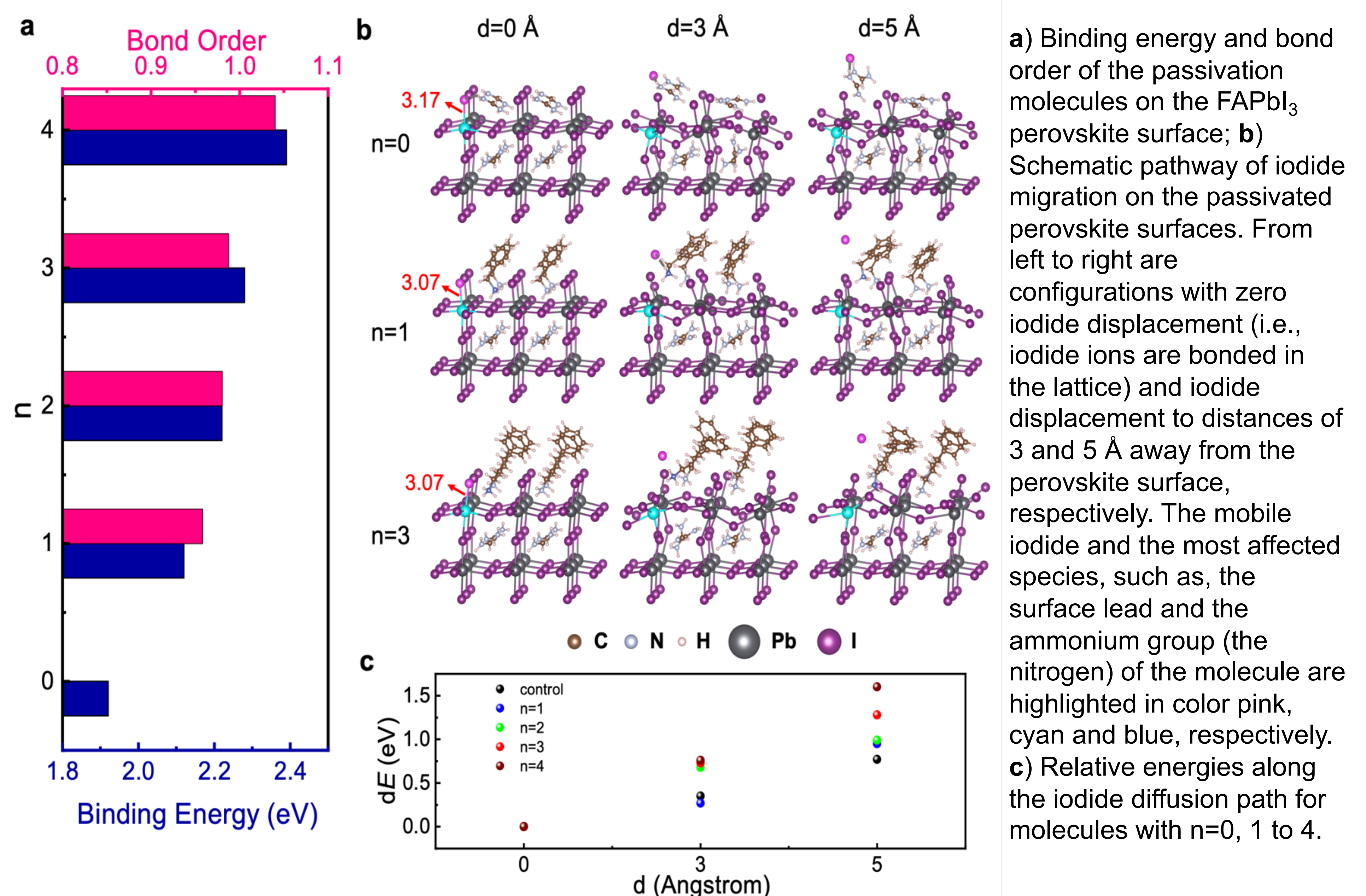
Device Characterization



ToF-SIMS Characterization



DFT calculation



Summary

Combining experimental characterization and theoretical modelling, we show that these molecules stabilize the perovskite through suppression of iodide ion migration. The stabilization effect is enhanced with increasing chain length due to the stronger binding of the molecules with the perovskite surface, as well as the increased steric hindrance to reconfiguration for accommodating ion migration. The passivation also reduces the surface defects, using the optimized passivation molecule, phenylpropylammonium iodide, we achieve devices with an efficiency of 17.5%, a radiance of 1282.8 W sr⁻¹ m⁻² and a T₅₀ half-lifetime of 130 hrs under 100 mA cm⁻².

Acknowledgement

This work was supported by the General Research Fund (RGC Ref No. 14307819) and NSFC/RGC Joint Research Scheme (Ref No. N_CUHK449/19) from the Research Grants Council of Hong Kong. The work done in the Netherlands was supported by funding from NWO START-UP and Computational Sciences for Energy Research (CSER) tenure track program of Shell and NWO (Project No. 15CST04-2).

¹ Department of Electronic Engineering, The Chinese University of Hong Kong, Shatin, N.T. Hong Kong SAR, China

² Materials Simulation and Modelling, Department of Applied Physics, Eindhoven University of Technology, 5600MB Eindhoven, The Netherlands

³ Center for Computational Energy Research, Department of Applied Physics, Eindhoven University of Technology, 5600 MB Eindhoven, The Netherlands

⁴ School of Electronic Science and Engineering, Xiamen University, Xiamen 361005, China

⁵ Biomolecular and Organic Electronics, Linköping University, S-581 83, Linköping, Sweden

⁶ Instrumental Analysis and Research Centre, Sun Yat-sen University, Guangzhou 510275, China

⁷ Computational Materials Science, Faculty of Science and Technology and MESA+ Institute for Nanotechnology, University of Twente, P.O. Box 217, 7500 AE Enschede, The Netherlands